

Search Notes

Application/Control No.

10/765,399

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

YOSHIDA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	22-24,29-33	1/31/2006	SWH
417	103,374	1/31/2006	SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east text search (see attached)	1/31/2006	SWH
USPGPUB text search (see attached)	1/31/2006	SWH